

**Notice of References Cited**

Application/Control No.

09/667,006

Applicant(s)/Patent Under  
Reexamination  
KWON ET AL.

Examiner

Thoi V Duong

Art Unit

2871

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6141123	10-2000	Nakashima et al.	359/3
	B	US-6432498 B1	08-2002	Ohtaki et al.	428/40.1
	C	<del>US-6141123</del>	<del>10-2000</del>	<del>Nakashima et al.</del>	<del>359/3</del>
	D	US-			
	E	US-			
	F	US-			
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	K	US-			
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	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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